Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,606	CHENG, YUH
Examiner	Art Unit
Linh T. Nauven	2627

SEARCHED				
Class	Subclass	Date	Examiner	
369	44.25	8/25/2006	LN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
attached to	nce search the search tes.	8/28/2006	LN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted and received search assitant from Wayne Young.	8/25/2006	LN	
Consulted with Wayne Young. No further search.	8/28/2006	LN	
East/JPO/EPO/IBM/Derwent/	8/28/2006	LN	